Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/042,846	HAIMOVSKY ET AL.	
Examiner	Art Unit	
Tse Chen	2116	

SEARCHED				
Class	Subclass	Date	Examiner	
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
text search only- see such pt priout	11/23 -	TSE
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